

**Search Notes**

Application/Control No.

10/601,596

Examiner

PAUL T. CHIN

Applicant(s)/Patent under  
Reexamination

CHANG ET AL.

Art Unit

3652

**SEARCHED**

Class	Subclass	Date	Examiner
updated	search	3/6/2007	PTC

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR